

TC40H390P/F

C²MOS DIGITAL INTEGRATED CIRCUIT
SILICON MONOLITHIC

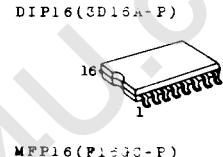
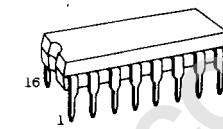
TC40H390 DUAL DECADE COUNTER

The TC40H390 is a dual decade counter with CLEAR function, and can be used as a binary/quinary /decimal counter. The CLEAR input is active at "H" level, and the CLOCK input is triggered at the falling edge of CLOCK.

For using a TC40H390 as a decimal counter, output QA shall be connected to input B directly.

For using a TC40H390 as a quinary counter, input clock signal shall be applied to input B directly.

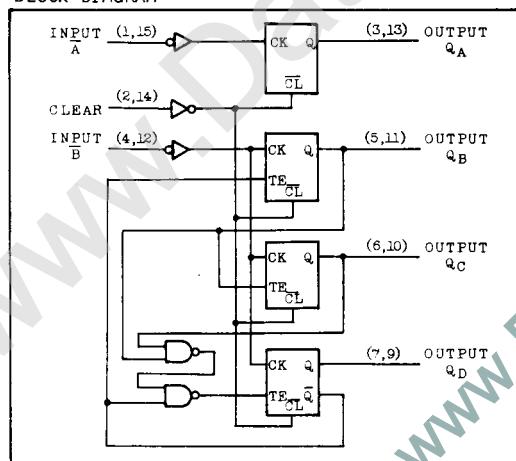
The function and pin assignment of this counter are the same as those of the TTL74390 and the LSTTL74LS390.



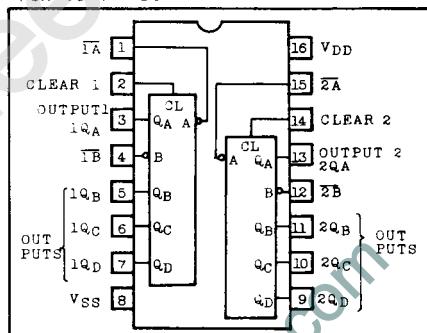
MAXIMUM RATINGS

CHARACTERISTIC	SYMBOL	RATING	UNIT
Supply Voltage	V _{DD}	V _{SS} -0.5 ~ V _{SS} +10	V
Input Voltage	V _{IN}	V _{SS} -0.5 ~ V _{DD} +0.5	V
Output Voltage	V _{OUT}	V _{SS} -0.5 ~ V _{DD} +0.5	V
Input Current	I _{IN}	±10	mA
Power Dissipation	P _D	300(DIP)/180(MFP)	mW
Storage Temperature	T _{stg}	-65 ~ 150	°C
Lead Temp./Time	T _{s0l}	260°C · 10 sec	

BLOCK DIAGRAM



PIN CONNECTION



COUNT SEQUENCE

(1) QA, INB Connection (2) QD, INA Connection

COUNT	OUTPUT				COUNT	OUTPUT			
	Q _A	Q _B	Q _C	Q _D		Q _B	Q _C	Q _D	Q _A
0	L	L	L	L	0	L	L	L	L
1	H	L	L	L	1	H	L	L	L
2	L	H	L	L	2	L	H	L	L
3	H	H	L	L	3	H	H	L	L
4	L	L	H	L	4	L	L	H	L
5	H	L	H	L	5	L	L	L	H
6	L	H	H	L	6	H	L	L	H
7	H	H	H	L	7	L	H	L	H
8	L	L	L	H	8	H	H	L	H
9	H	L	L	H	..	L	L	H	H

TC40H390P/F**RECOMMENDED OPERATING CONDITIONS ($V_{SS}=0.0V$)**

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Supply Voltage	V_{DD}	—	2.0	—	8.0	V
Input Voltage	V_{IN}	—	0	—	V_{DD}	V
Operating Temperature	T_{opr}	—	-40	—	85	°C

ELECTRICAL CHARACTERISTICS ($V_{SS}=0.0V$)

CHARACTERISTIC	SYMBOL	TEST CONCITION	V_{DD} (V)	-40°C		25°C			85°C		UNIT
				MIN.	MAX.	MIN.	TYP.	MAX.	MIN.	MAX.	
High Level Output Voltage	V_{OH}	$ I_{OUT} < 1\mu A$ $V_{IN}=V_{SS}$	5	4.95	—	4.95	—	—	4.95	—	V
Low Level Output Voltage	V_{OL}	$ I_{OUT} < 1\mu A$ $V_{IN}=V_{DD}$	5	—	0.05	—	0.0	0.05	—	0.05	V
High Level Output Current	I_{OH}	$V_{OH}=4.6V$ $V_{IN}=V_{SS}$	5	-0.52	—	-0.44	—	—	-0.36	—	mA
Low Level Output Current	I_{OL}	$V_{OL}=0.4V$ $V_{IN}=V_{DD}$	5	1.4	—	1.1	—	—	0.8	—	mA
High Level Input Voltage	V_{IH}	$ I_{OUT} < 1\mu A$ $V_{OUT}=0.5V$	5	4.0	—	4.0	—	—	4.0	—	V
Low Level Input Voltage	V_{IL}	$V_{OUT}=4.5V$ $V_{IN}=V_{SS}, V_{DD}$	5	—	1.0	—	—	1.0	—	1.0	V
Input "H" Level	I_{IH}	$V_{IH}=8.0$	8	—	0.3	—	10^{-5}	0.3	—	1.0	μA
Current "L" Level	I_{IL}	$V_{IL}=0.0V$	8	—	-0.3	—	-10^{-5}	-0.3	—	-1.0	μA
Quiescent Supply Current	I_{DD}	* $V_{IN}=V_{SS}, V_{DD}$	5	—	12.5	—	10^{-3}	12.5	—	75	μA

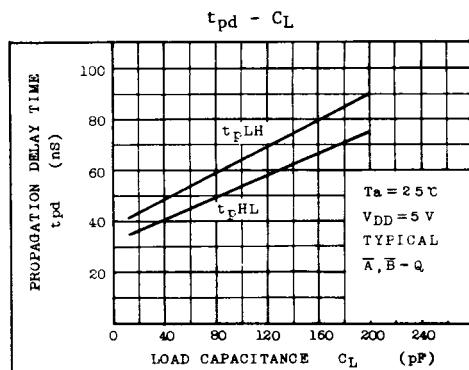
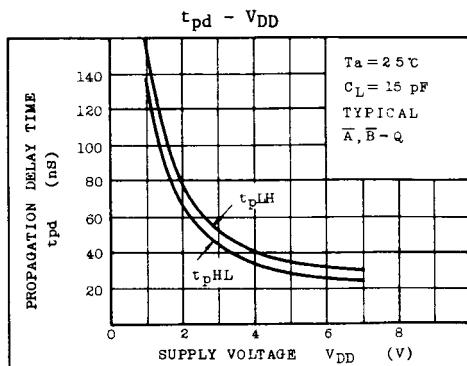
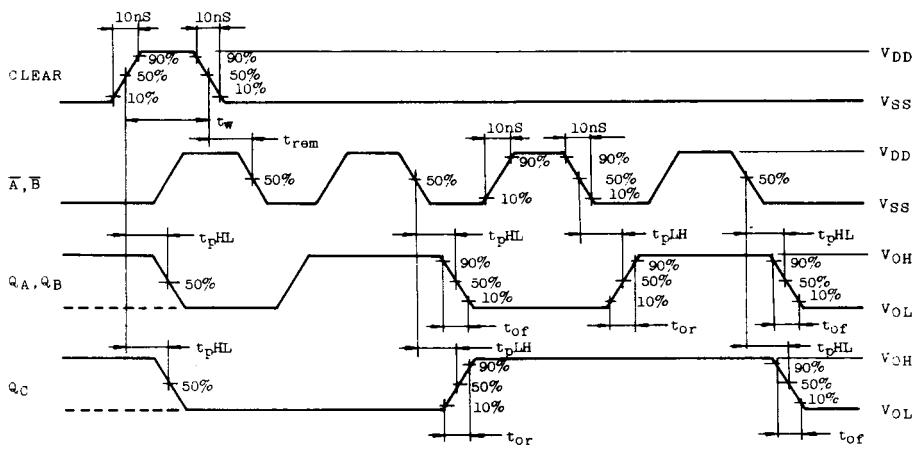
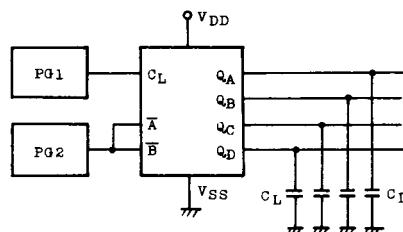
* All valid input combinations.

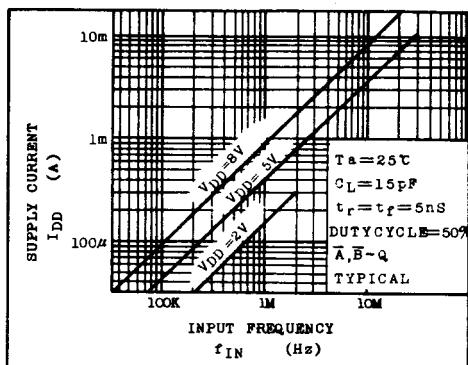
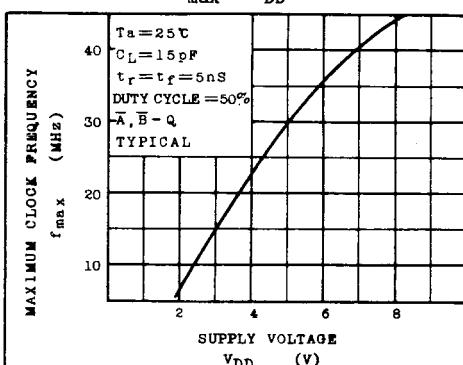
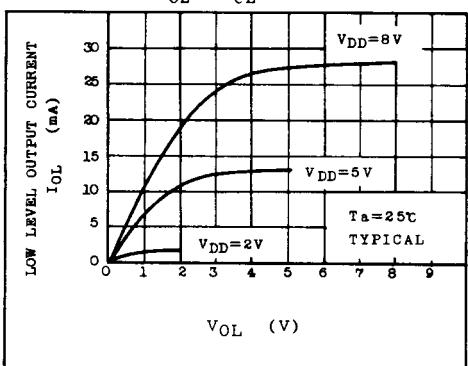
SWITCHING CHARACTERISTICS ($T_a=25^\circ C$, $V_{SS}=0V$, $V_{DD}=5V$, $C_L=15pF$)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Output Rise Time	t_{or}	CLCOK - Q	—	18	35	ns
Output Fall Time	t_{of}		—	15	30	
Propagation Delay Time	t_{pHL}	CLEAR - Q	—	42	63	ns
High-Low Level Propagation Delay Time	t_{pHL}		—	36	54	
Maximum Clock Rise/Fall Time	$t_{rf\phi}$	CLEAR - Q	1.0	100	—	μs
Minimum Clear Pulse Width	t_w		—	20	35	ns
Minimum Clear Removal Time	t_{rem}	CLEAR - Q	—	10	20	ns
Maximum Clock Frequency	f_{MAX}		15	30	—	MHz
Input Capacitance	C_{IN}	CLEAR - Q	—	5	—	—

TC40H390P/F

SWITCHING TIME TEST CIRCUIT AND WAVEFORM



TC40H390P/F**I_{DD} - f_{IN}****f_{max} - V_{DD}****I_{OL} - V_{CL}****I_{OH} - (V_{DD} - V_{OH})**